MSKSEMI 美森科













ESD

15

TSS

MOV

GDT

PLED

MMSD4148T1G-MS

Product specification





Silicon Epitaxial Planar Switching Diode

Features

- SOD-123 package
- Fast switching

Reference News

SOD-123	CIRCUIT DIAGRAM	MARKING
1		51*

PINNING

PIN	DESCRIPTION	
1	Cathode	
2	Anode	

Absolute Maximum Ratings (T_a = 25℃)

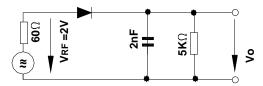
Parameter		Symbol	Value	Unit
Peak Reverse Voltage		V_{RM}	100	V
Reverse Voltage		V_R	75	V
Average Rectified Forward Current		I _{F(AV)}	150	mA
Non-repetitive Peak Forward Surge Current	at t = 1 s at t = 1 ms at t = 1 µs	I _{FSM}	0.5 1 4	А
Power Dissipation		P _{tot}	400	mW
Thermal Resistance from Junction to Ambient Air		R _{eJA}	312	°C/W
Junction Temperature		Tj	150	$^{\circ}$
Storage Temperature Range		T _{stg}	- 65 to + 150	${\mathbb C}$

Characteristics at Ta = 25°C

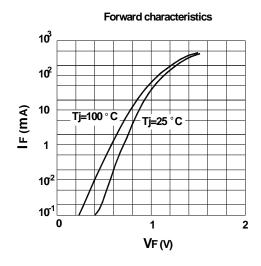
Parameter	Symbol	Min.	Max.	Unit
Forward Voltage				
at I _F = 1 mA	V_{F}	-	0.715 0.855	V
at $I_F = 10 \text{ mA}$	V F	-	1	,
at $I_F = 50 \text{ mA}$		-	1.25	
at I _F = 150 mA		-	1.20	
Peak Reverse Current				
at $V_R = 75 \text{ V}$		-	1	μA
at $V_R = 20 \text{ V}$	I _R	-	25	nA
at $V_R = 75 \text{ V}$, $T_J = 150 ^{\circ}\text{C}$		-	50	μA
at $V_R = 25 \text{ V}, T_J = 150^{\circ}\text{C}$		-	30	μA
Total Capacitance	C _τ		2	pF
at $V_R = 0 V$, $f = 1 MHz$	OT .	-		ρΓ
Reverse Recovery Time at I_{rr} = 0.1 X I_{Rr} I_{F} = I_{Rr} = 10 mA, R_{L} = 100 Ω	t _{rr}	-	4	ns

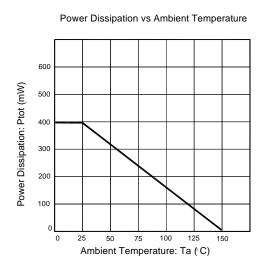


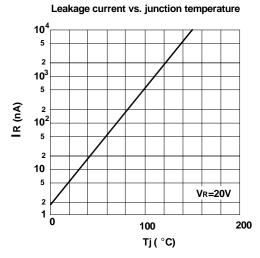
Typical Characteristics

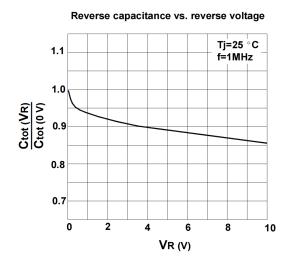


Rectification Efficiency Measurement Circuit



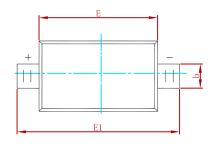


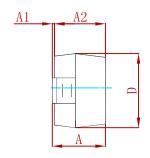


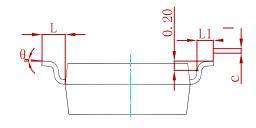




PACKAGE MECHANICAL DATA

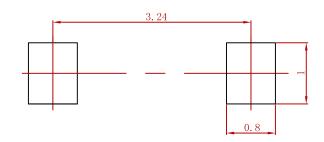






Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.450	0.650	0.018	0.026	
С	0.080	0.150	0.003	0.006	
D	1.500	1.700	0.059	0.067	
Е	2.600	2.800	0.102	0.110	
E1	3.550	3.850	0.140	0.152	
L	0.500 REF		0.020 REF		
L1	0.250	0.450	0.010	0.018	
θ	0°	8°	0°	8°	

Suggested Pad Layout



Note:

- 1. Controlling dlmension: in millmeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout Is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
MMSD4148T1G-MS	SOD-123	3000



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